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Applicant(s)/Patent under Reexamination

10/500,013

Examiner

PINES ET AL.

Art Unit

Eric D. Bertram

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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Inventor search on eDAN	11/9/2007	EDB
EAST notes - see attached	11/9/2007	EDB
Consulted with Carl Layno	11/9/2007	EDB